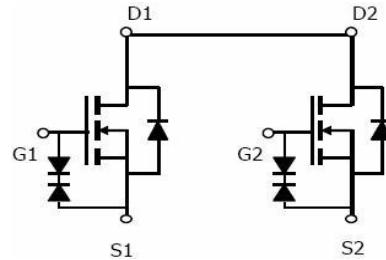


Dual N-Channel Enhancement Mode Power MOSFET

Description

The MX3388 uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge.it can be used In a wide variety of applications. It is ESD protected

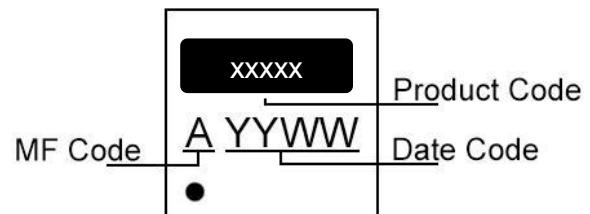


General Features

- ◆ $V_{DS} = 20V$, $I_D = 8A$
- ◆ @ $V_{GS}=4.5V$ $R_{DS(ON)}(\text{Typ.})=10m\Omega$
- ◆ @ $V_{GS}=3.8V$ $R_{DS(ON)}(\text{Typ.})=10.6m\Omega$
- ◆ @ $V_{GS}=2.5V$ $R_{DS(ON)}(\text{Typ.})=15.5m\Omega$
ESD Rating: 2000V HBM

High density cell design for ultra low Rdson
Fully characterized Avalanche voltage and current

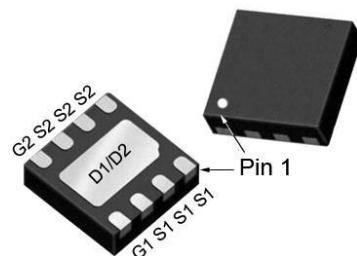
Schematic diagram



Marking Description

Application

PWM Power switching application
Hard Switched and High Frequency Circuits
Uninterruptible Power Supply



DFN3X3-8L top view

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|---------------------|------------|------|
| Drain-Source Voltage | V_{DS} | 20 | V |
| Gate-Source Voltage | V_{GS} | ± 12 | V |
| Drain Current-Continuous | I_D | 8 | A |
| Drain Current-Continuous($T_A=100^\circ C$) | $I_D (100^\circ C)$ | 6 | A |
| Pulsed Drain Current | I_{DM} | 32 | A |
| Maximum Power Dissipation | P_D | 2.5 | W |
| Operating Junction and Storage Temperature Range | T_J, T_{STG} | -55 To 150 | °C |

Thermal Characteristic

| | | | |
|--|------------------|----|------|
| Thermal Resistance, Junction-to-Ambient (Note 2) | R _{θJA} | 50 | °C/W |
|--|------------------|----|------|

Notes:

1. Pulse width limited by maximum junction temperature.
2. The value of R_{θJA} is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.

Electrical Characteristics (T_A=25°C unless otherwise noted)

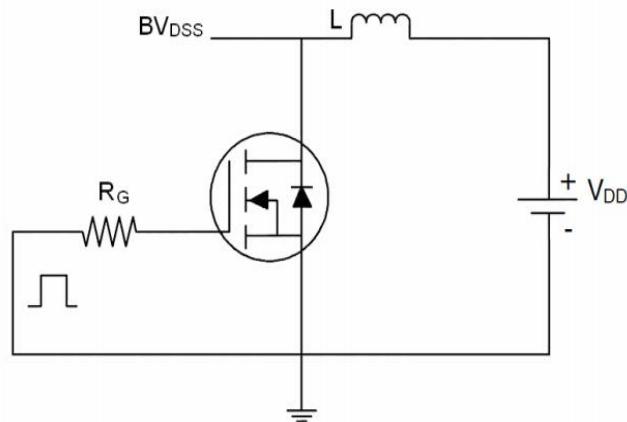
| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|---|---------------------|---|-----|------|------|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V, I _D =250μA | 20 | - | - | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =20V, V _{GS} =0V | - | - | 1 | μA |
| Parameter | | | | | | |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±12V, V _{DS} =0V | - | - | ±100 | μA |
| On Characteristics (Note 2) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} , I _D =250μA | 0.4 | 0.75 | 1.2 | V |
| Drain-Source On-State Resistance | R _{DSON} | V _{GS} =4.5V, I _D =8A | - | 10 | 13.5 | mΩ |
| | | V _{GS} =3.8V, I _D =6A | - | 10.6 | 15 | mΩ |
| | | V _{GS} =2.5V, I _D =4A | - | 15.5 | 21 | mΩ |
| Forward Transconductance | g _F | V _{DS} =5V, I _D =8A | - | 15 | - | S |
| Dynamic Characteristics (Note 3) | | | | | | |
| Input Capacitance | C _{iss} | V _{DS} =15V, V _{GS} =0V, F=1.0MHz | - | 735 | - | PF |
| Output Capacitance | C _{oss} | | - | 83 | - | PF |
| Reverse Transfer Capacitance | C _{rss} | | - | 81 | - | PF |
| Switching Characteristics (Note 3) | | | | | | |
| Turn-on Delay Time | t _{d(on)} | V _{DD} =10V, R _L =1A V _{GS} =5V, R _{GEN} =6Ω | - | 7.2 | - | nS |
| Turn-on Rise Time | t _r | | - | 36 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | | - | 45 | - | nS |
| Turn-Off Fall Time | t _f | | - | 15 | - | nS |
| Total Gate Charge | Q _g | V _{DS} =10V, I _D =6A, V _{GS} =4.5V | - | 11 | - | nC |
| Gate-Source Charge | Q _{gs} | | - | 2.2 | - | nC |
| Gate-Drain Charge | Q _{gd} | | - | 4.1 | - | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage (Note 2) | V _{SD} | V _{GS} =0V, I _s =1A | - | - | 1.2 | V |
| Diode Forward Current (Note 1) | I _s | | - | - | 3.5 | A |

Notes:

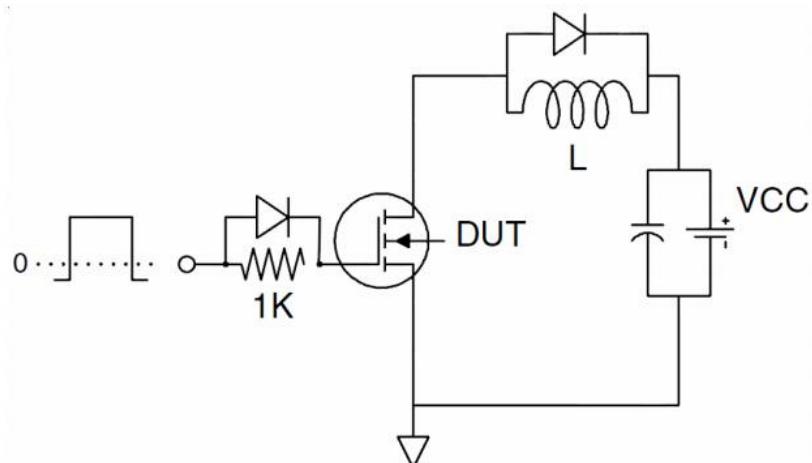
2. Repetitive Rating: Pulse width limited by maximum junction temperature.
3. Surface Mounted on FR4 Board, t ≤ 10 sec.
4. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
5. Guaranteed by design, not subject to production

Test Circuit

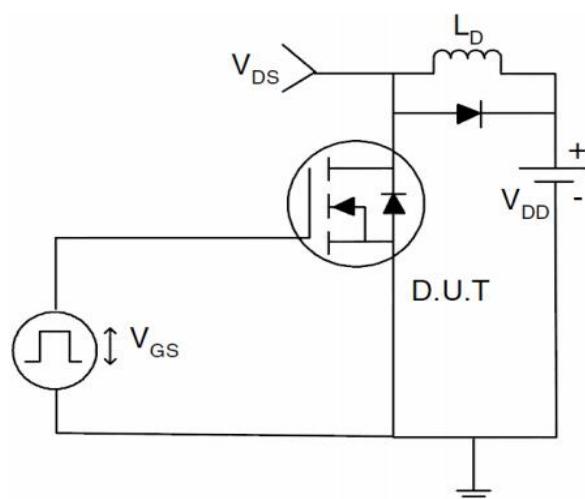
1) E_{AS} Test Circuits

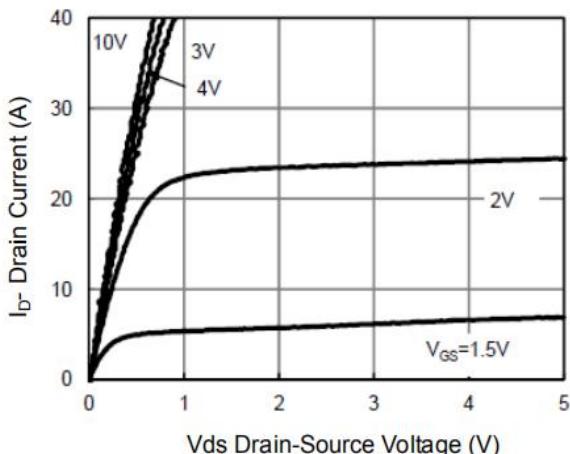
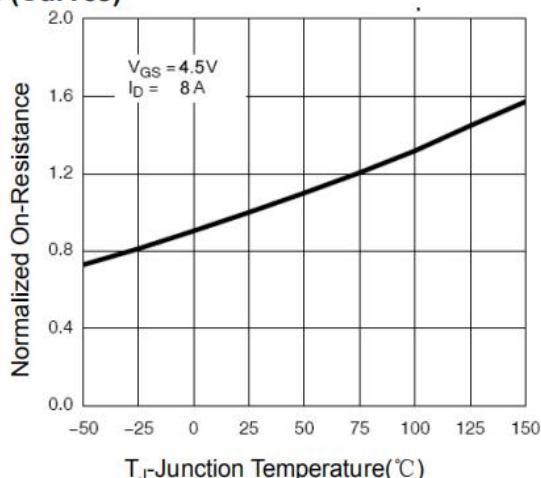
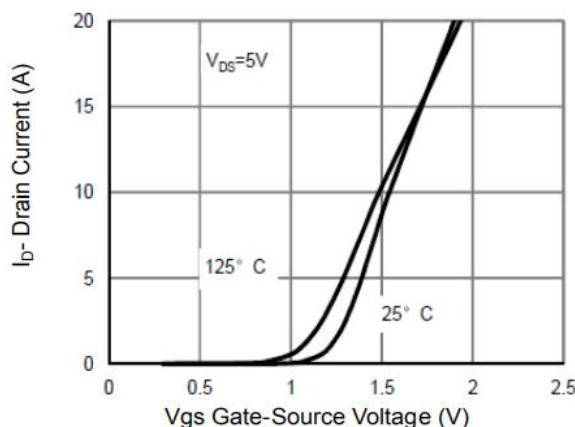
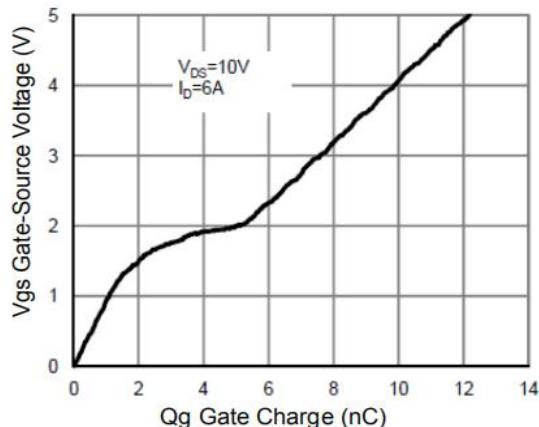
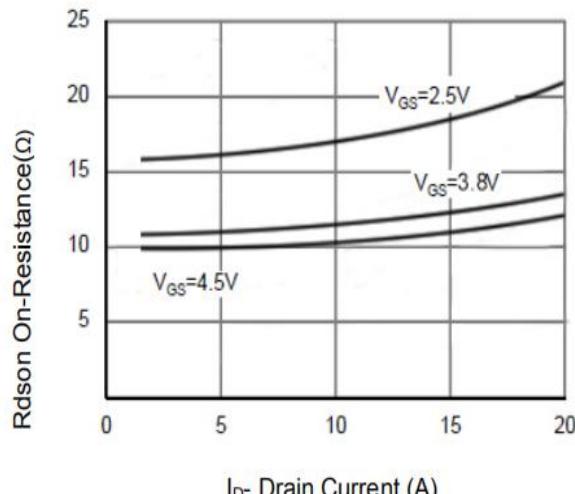
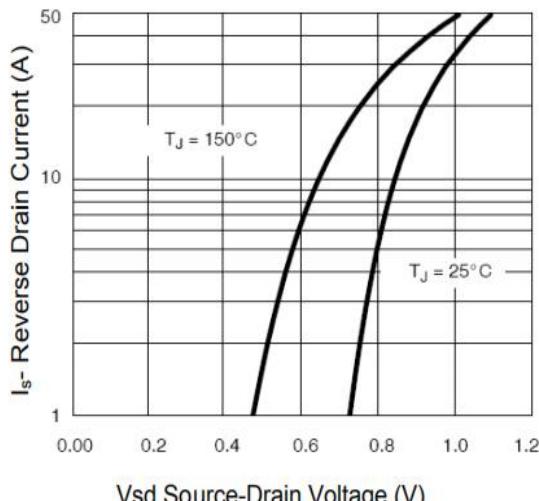


2) Gate Charge Test Circuit:



3) Switch Time Test Circuit:



Typical Electrical and Thermal Characteristics (Curves)

Figure 1 Output Characteristics

Figure 4 Rdson-JunctionTemperature

Figure 2 Transfer Characteristics

Figure 5 Gate Charge

Figure 3 Rdson- Drain Current

Figure 6 Source- Drain Diode Forward

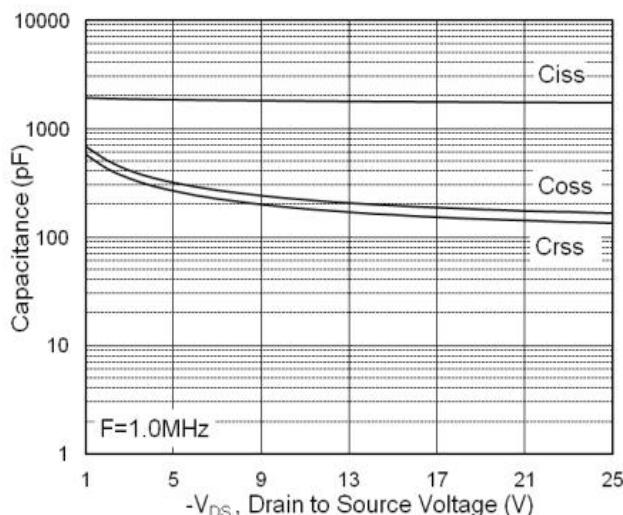


Figure 7 Capacitance vs Vds

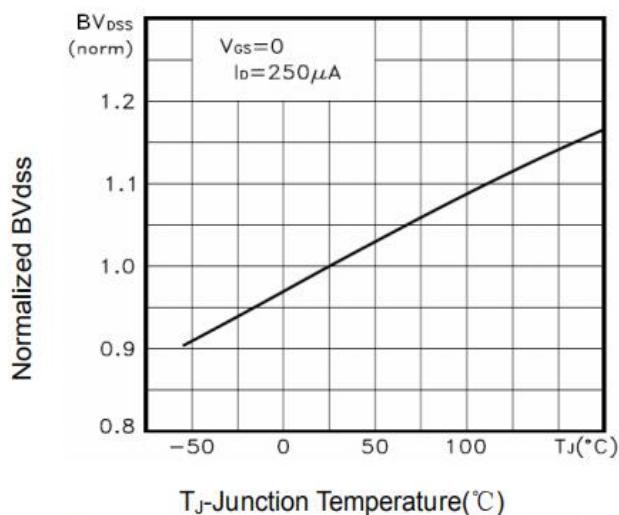


Figure 9 BV_{DSS} vs Junction Temperature

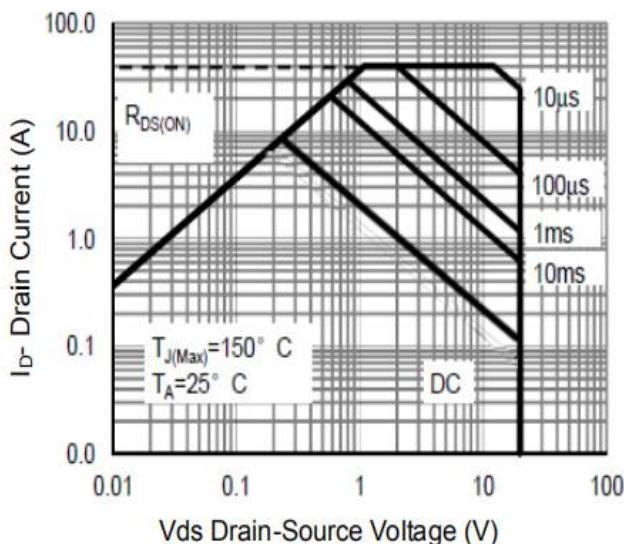


Figure 8 Safe Operation Area

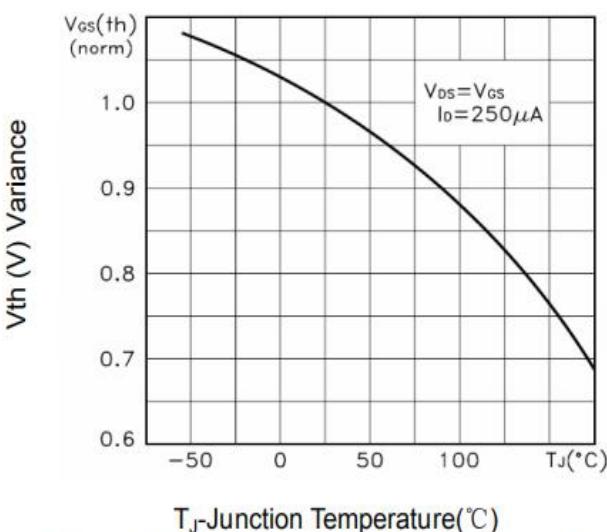


Figure 10 $V_{GS(\text{th})}$ vs Junction Temperature

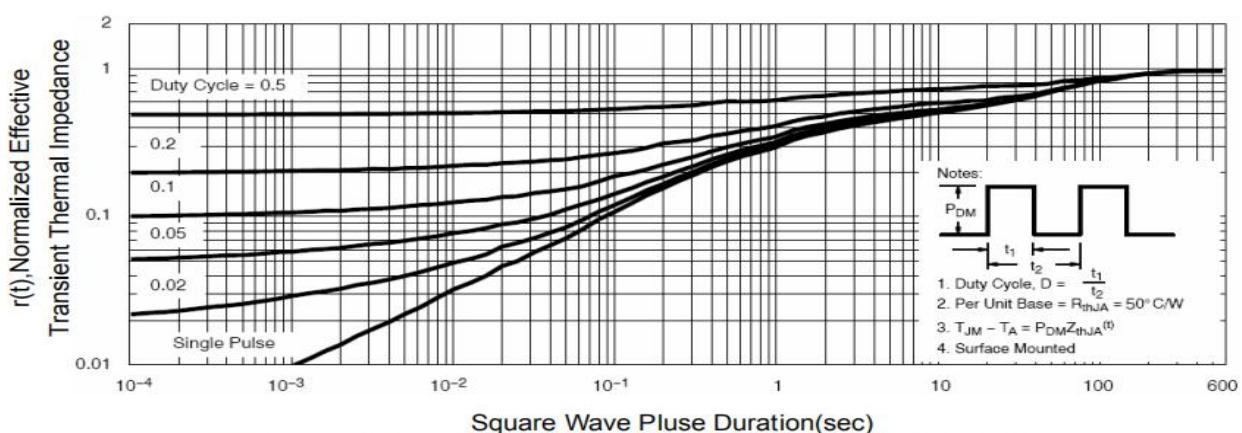


Figure 11 Normalized Maximum Transient Thermal Impedance

Package Dimension**DFN 3x3 MECHANICAL DATA**

| Dimension | mm | | | Dimension | mm | | |
|-----------|-------|------|-------|-----------|------|-------|------|
| | Min. | Typ. | Max. | | Min. | Typ. | Max. |
| A | 0.7 | | 0.8 | I | | 0.203 | |
| B | 0.25 | | 0.35 | J | 2.2 | | 2.4 |
| C | 0.2 | | | K | 1.4 | | 1.6 |
| D | 2.924 | | 3.076 | | | | |
| E | 2.924 | | 3.076 | | | | |
| F | 0.324 | | 0.476 | | | | |
| G | | 0.65 | | | | | |
| H | 0 | | 0.05 | | | | |

